

Notice of References Cited	Application/Control No. 10/693,468	Applicant(s)/Patent Under Reexamination LOOK, KEVIN T.	
	Examiner Viet Q. Nguyen	Art Unit 2818	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,341,016	08-1994	Prall et al.	257/412
*	B	US-6,671,205	12-2003	Look, Kevin T.	365/185.18
*	C	US-6,496,416	12-2002	Look, Kevin T.	365/185.18
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-		VIET Q. NGUYEN PRIMARY EXAMINER	
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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